TOSHIBA CMOS Linear Integrated Circuit Silicon Monolithic

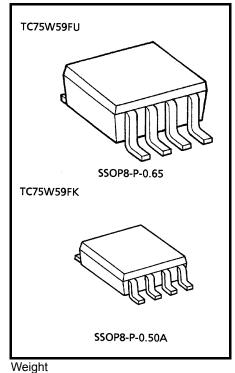
# TC75W59FU,TC75W59FK

#### **Dual Comparator**

TC75W59 is a CMOS type general-purpose dual comparator capable of single power supply operation and using lower supply currents than the conventional bipolar comparators. Its open drain output forms wired OR with other open drain outputs.

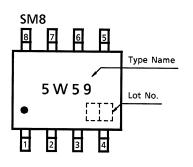
#### Features

- Low supply current: IDD = 200µA (typ.)
- Single power supply operation
- Wide common mode input voltage range:  $V_{SS} \sim V_{DD} = 0.9V$
- Open drain output circuit
- Low input bias current
- Small package

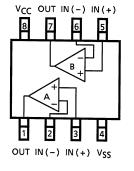


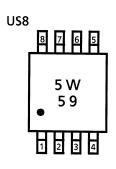
Weight SSOP8-P-0.65: 0.021g (typ.) SSOP8-P-0.50A: 0.01g (typ.)

#### Pin Connection (Top View)



## Marking (Top View)





#### Absolute Maximum Ratings (Ta = 25°C)

Characteristic	Symbol	Rating	Ν
Supply voltage	V <sub>DD</sub> , V <sub>SS</sub>	±3.5 or 7	V
Differential input voltage	DVIN	±7	V
Input voltage	V <sub>IN</sub>	V <sub>SS</sub> ~V <sub>DD</sub>	V
Output current	Ι <sub>Ο</sub>	±35	mA
Power dissipation	D-	250 (TC75W59FU)	mW
	PD	200 (TC75W59FK)	IIIVV
Operating temperature	T <sub>opr</sub>	-40~85	°C
Storage temperature	T <sub>stg</sub>	-55~125	°C

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings and the operating ranges.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

Note: Since this product sometimes brings about latchcap, which is peculiar to CMOS devices, note the following points:

- Don't raise the voltage level of I/O pins beyond V<sub>DD</sub>, nor lower it below V<sub>SS</sub>. Consider the timing for power supply, too.
- Don't let any abnormal noise enter the device.

## Electrical Characteristics (V<sub>DD</sub> = 5V, V<sub>SS</sub> = GND, Ta = 25°C)

Characteristic	Symbol	Test Circuit	Test Condition	Min	Тур.	Max	Unit
Input offset voltage	V <sub>IO</sub>	-	—	_	±1	±7	mV
Input offset current	I <sub>IO</sub>	_	—	_	1	—	pА
Input bias current	l	_	—	_	1	—	pА
Common mode input voltage	CMVIN	_	—	0	_	4.1	V
Supply current	I <sub>DD</sub> (Note)	_	—	_	220	440	μA
Voltage gain	GV	_	—	_	94	—	dB
Sink current	I <sub>sink</sub>	_	V <sub>OL</sub> = 0.5V	13	25	—	mA
Output leak current	ILEAK	_	V <sub>O</sub> = 5V	_	5	—	nA
Output voltage	V <sub>OL</sub>	_	I <sub>sink</sub> = 5.0mA	_	0.1	0.3	V
Operating supply voltage	V <sub>DD</sub>	_	—	1.8	_	7.0	V
Propagation delay time (turn on)	t <sub>PLH</sub> (1)	_	Over drive = 100mV	_	200	—	ns
	t <sub>PLH</sub> (2)	—	TTL step input		140	_	
Propagation delay time (turn off)	t <sub>PHL</sub> (1)	_	Over drive = 100mV		80	_	ns
	t <sub>PHL</sub> (2)	_	TTL step input	_	60	—	
Response time	t <sub>TLH</sub>	—	Over drive = 100mV	_	160	—	ns
	t <sub>THL</sub>	—	Over drive = 100mV		3	—	

#### Electrical Characteristics (V<sub>DD</sub> = 3V, V<sub>SS</sub> = GND, Ta = 25°C)

Characteristic	Symbol	Test Circuit	Test Condition	Min	Тур.	Max	Unit
Input offset voltage	V <sub>IO</sub>	-	—	_	±1	±7	mV
Input offset current	I <sub>IO</sub>	-	—		1	—	pА
Input bias current	lj	-	—	_	1	—	pА
Common mode input voltage	CMVIN	_	—	0	_	2.1	V
Supply current	I <sub>DD</sub> (Note)	_	_	_	200	400	μA
Sink current	l <sub>sink</sub>	_	V <sub>OL</sub> = 0.5V	6	18	_	mA
Output leak current	ILEAK	_	V <sub>O</sub> = 3V	_	5	_	nA
Output voltage	V <sub>OL</sub>	_	I <sub>sink</sub> = 5.0mA	_	0.15	0.35	V
Propagation delay time (turn on)	t <sub>PLH</sub>	_	Over drive = 100mV	_	160	_	ns
Propagation delay time (turn off)	tPHL	_	Over drive = 100mV	_	70	_	ns
Response time	t <sub>TLH</sub>	-	Over drive = 100mV	—	170	—	ns
	t <sub>THL</sub>	—	Over drive = 100mV	_	3	_	

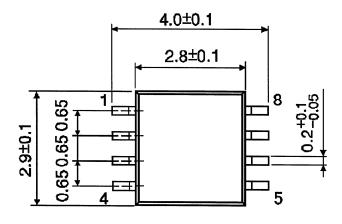
Note: Since this product causes an increase in current consumption with a rise in operational frequency, make sure that power consumption does not exceed the allowable dissipation.

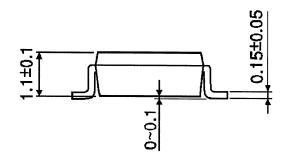
# **TOSHIBA**

#### **Package Dimensions**

SSOP8-P-0.65

Unit: mm





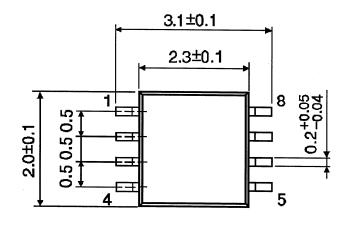
Weight: 0.021g(typ.)

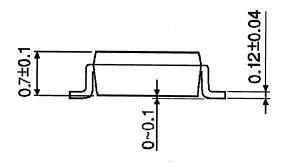
# **TOSHIBA**

## Package Dimensions

SSOP8-P-0.50A

Unit: mm





Weight: 0.01g(typ.)

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20070701-EN GENERAL

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